

Search Notes

Application/Control No.

10/674,485

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

KELLIHER ET AL.

Art Unit

2636

SEARCHED

Class	Subclass	Date	Examiner
340	502	8/2/2005	JAT
	539.1	8/2/2005	JAT
	539.11	8/2/2005	JAT
	541	8/2/2005	JAT
	573.1	8/2/2005	JAT
368	10	8/2/2005	JAT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner